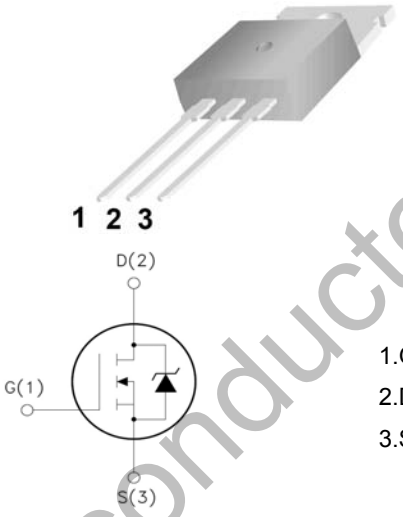
WGP20N60J

Features:

- ☐ Low Intrinsic Capacitances.
- ☐ Excellent Switching Characteristics.
- ☐ Extended Safe Operating Area.
- ☐ Unrivalled Gate Charge :Qg=75 nC (Typ.).
- ☐ BVDSS=600V,I_D=20A
- ☐ R_{DS}(on) : 0.18Ω (Max) @V_G=10V
- ☐ 100% Avalanche Tested

TO-220

RoHS COMPLIANT



1.Gate (G)
2.Drain (D)
3.Source (S)

Absolute Maximum Ratings (Ta=25℃ unless otherwise noted)

Symbol	Parameter		Value	Unit
V_{DSS}	Drain-Source Voltage		600	V
I_D	Drain Current	T_C=25℃	20	A
		T_C=100℃	12.6	
V_{GSS}	Gate-Source Voltage		±30	V
E_{AS}	Single Pulse Avalanche Energy (note1)		690	mJ
I_{AR}	Avalanche Current (note2)		20	A
P_D	Power Dissipation (Tc=25℃)		126	W
T_j	Junction Temperature(Max)		150	℃
T_{stg}	Storage Temperature		-55~+150	
TL	Maximum lead temperature for soldering purpose,1/8" from case for 5 seconds		300	

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance,Junction to Case	-	3.2	℃/W
$R_{\theta JA}$	Thermal Resistance,Junction to Ambient	-	62.5	

Electrical Characteristics (Ta=25℃ unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250μA，V_{GS}=0	600	-	-	V
△BVDSS/△TJ	Breakdown Voltage Temperature Coefficient	I_D=250μA ,Reference to 25℃	-	0.71	-	V/℃
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=600V, V_{GS}=0V	-	-	10	μA
		V_{DS}=480V, Tc=125℃			100	
I_{GSSF}	Gate-body leakage Current, Forward	V_{GS}=+30V, V_{DS}=0V	-	-	100	nA
I_{GSSR}	Gate-body leakage Current, Reverse	V_{GS}=-30V, V_{DS}=0V	-	-	-100	
On Characteristics						
$V_{GS(TH)}$	Gate Threshold Voltage	I_D=250μA,V_{DS}=V_{GS}	2	-	4	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	I_D=10A,V_{GS}=10V	-	0.15	0.19	Ω
Dynamic Characteristics						
Ciss	Input Capacitance	V_{DS}=25V，V_{GS}=0，f=1.0MHz	-	2370	3080	pF
Coss	Output Capacitance		-	1280	1665	
Crss	Reverse Transfer Capacitance		-	95	-	
Switching Characteristics						
Td(on)	Turn-On Delay Time	V_{DD}=300V，I_D=20A R_G=25Ω (Note 3,4)	-	62	135	ns
Tr	Turn-On Rise Time		-	140	290	
Td(off)	Turn-Off Delay Time		-	230	470	
Tf	Turn-Off Rise Time		-	65	140	
Qg	Total Gate Charge	V_{DS}=480V,V_{GS}=10V，I_D=20A (Note 3,4)	-	75	98	nC
Qgs	Gate-Source Charge		-	13	-	
Qgd	Gate-Drain Charge		-	36	-	
Drain-Source Diode Characteristics and Maximum Ratings						
Is	Max. Diode Forward Current	-	-	-	20	A
I_{SM}	Max. Pulsed Forward Current	-	-	-	60	A
V_{SD}	Diode Forward Voltage	I_D=20A	-	-	1.4	V
Trr	Reverse Recovery Time	I_S=20A,V_{GS} =0V diF/dt=100A/μs (Note3)	530	-	-	ns
Qrr	Reverse Recovery Charge		3.69	-	-	μC

Notes : 1, L=3.45mH, IAS=20A, VDD=50V, RG=25Ω, Starting TJ =25°C
2, Repetitive Rating : Pulse width limited by maximum junction temperature
3, Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%
4, Essentially Independent of Operating Temperature

Typical Characteristics

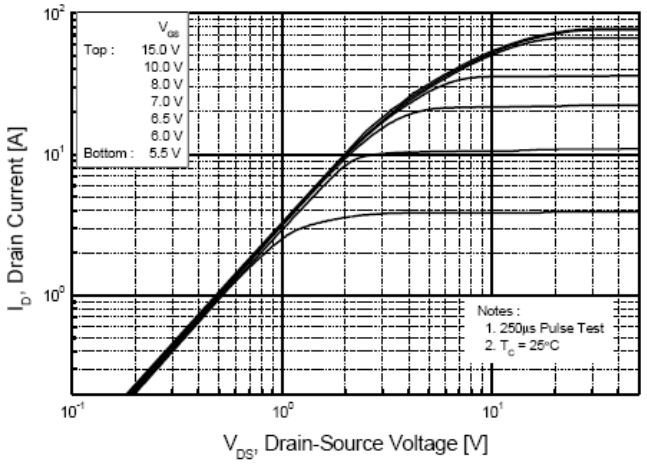


Fig. 1. On-Region Characteristics

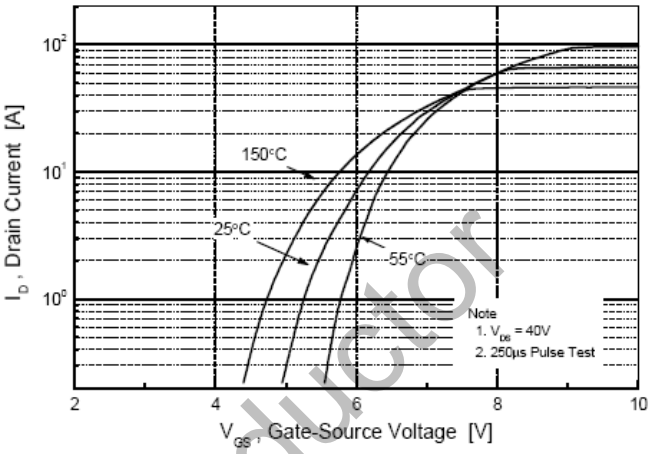


Fig. 2. Transfer Characteristics

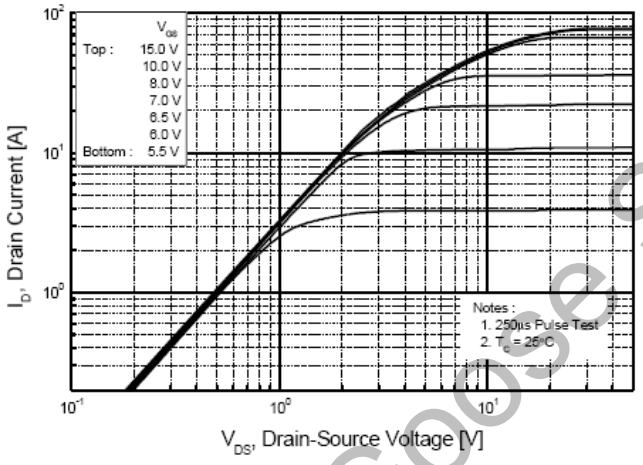


Fig. 3. On-Resistance Variation vs Drain Current and Gate Voltage

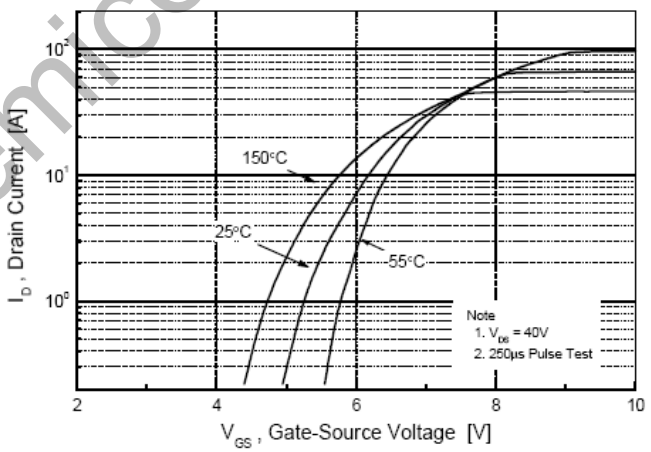


Fig. 4. Body Diode Forward Voltage Variation with Source Current and Temperature

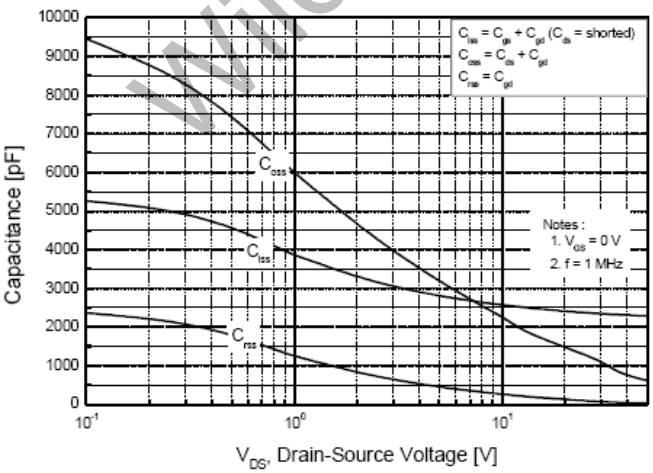


Fig. 5. Capacitance Characteristics

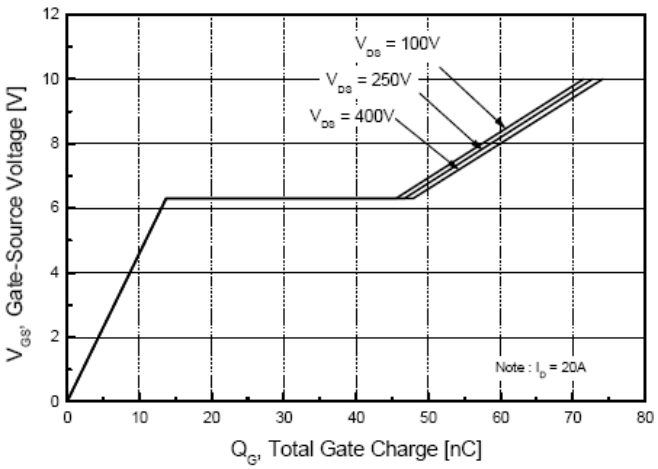


Fig. 6. Gate Charge Characteristics

Typical Characteristics (Continued)

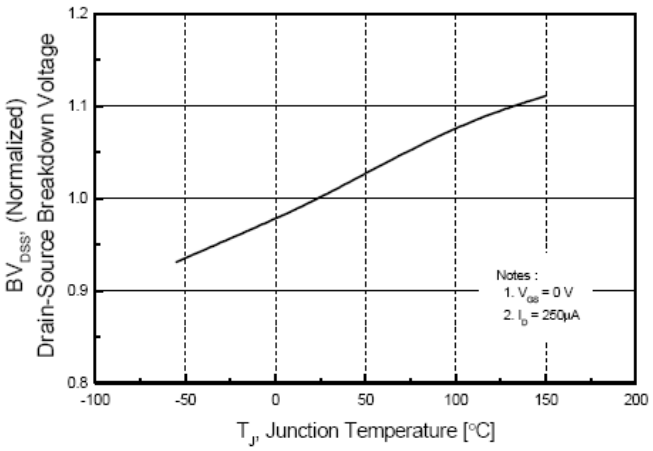


Fig. 7. Breakdown Voltage Variation vs Temperature

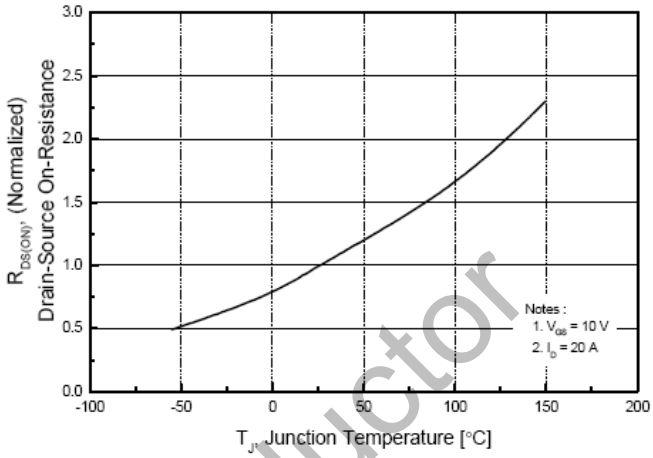


Fig. 8. On-Resistance Variation vs Temperature

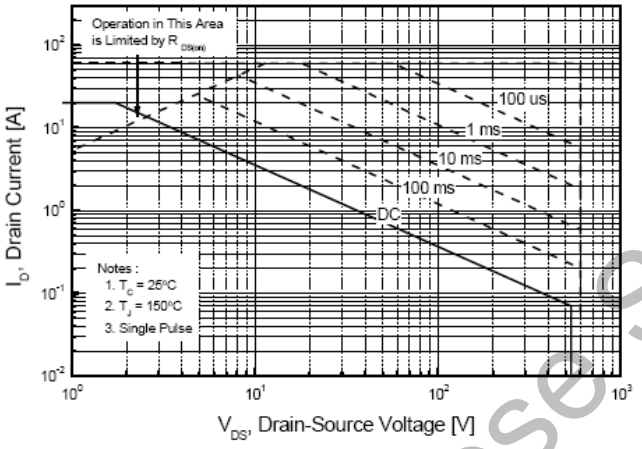


Fig. 9. Maximum Safe Operating Area

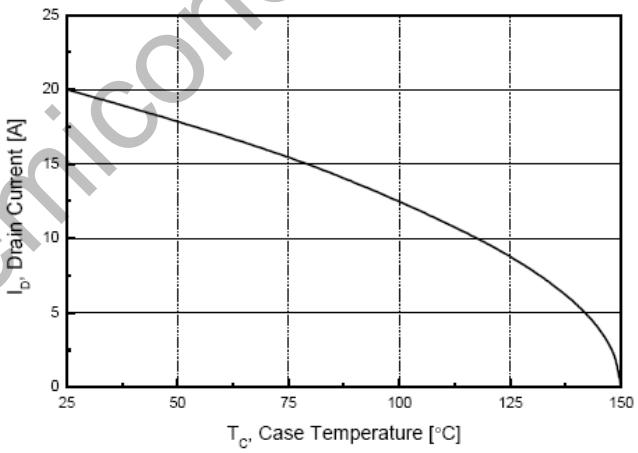


Fig. 10. Maximum Drain Current vs Case Temperature

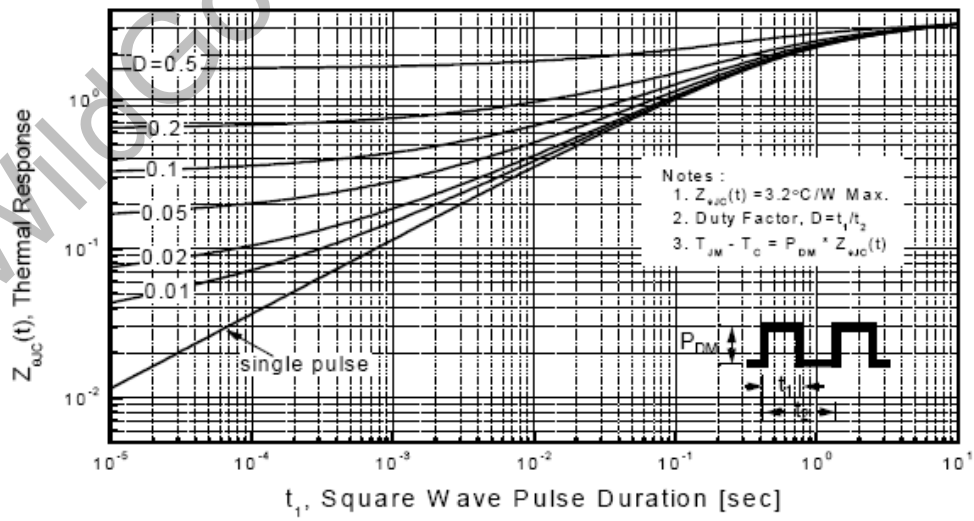
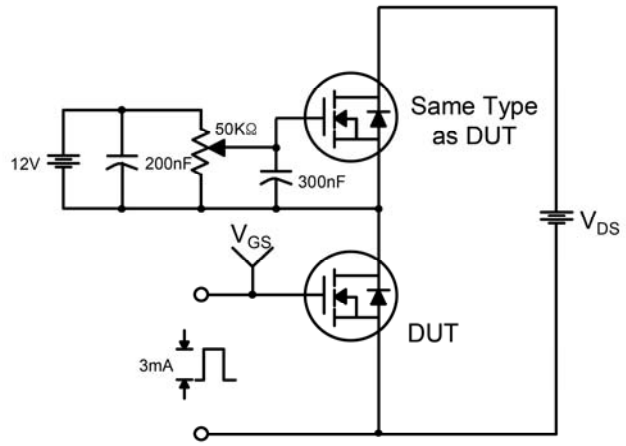
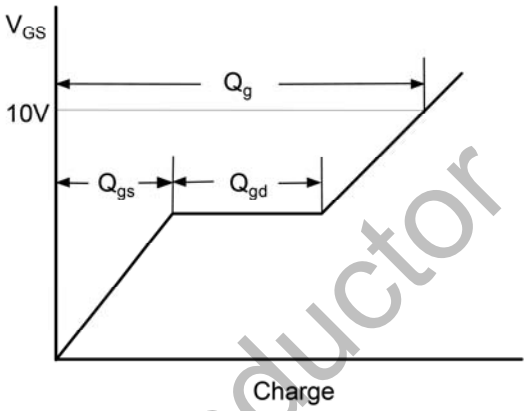


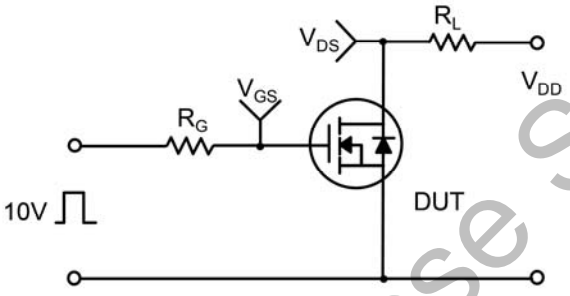
Fig 11. Transient Thermal Response Curve

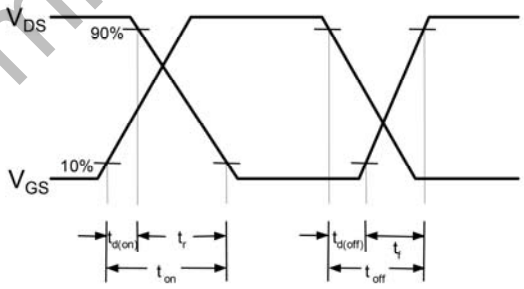
Gate Charge Test Circuit & Waveform



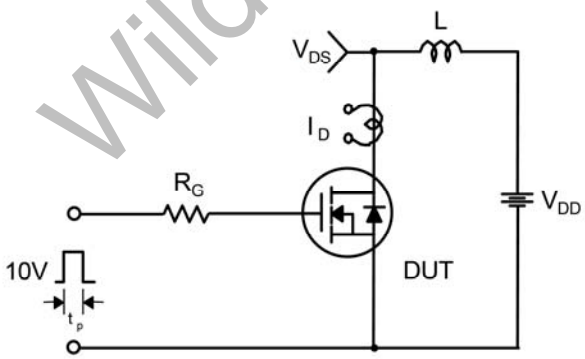


Resistive Switching Test Circuit & Waveforms

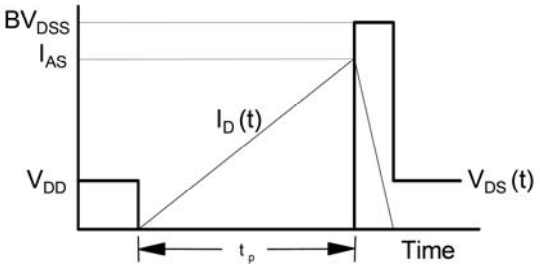




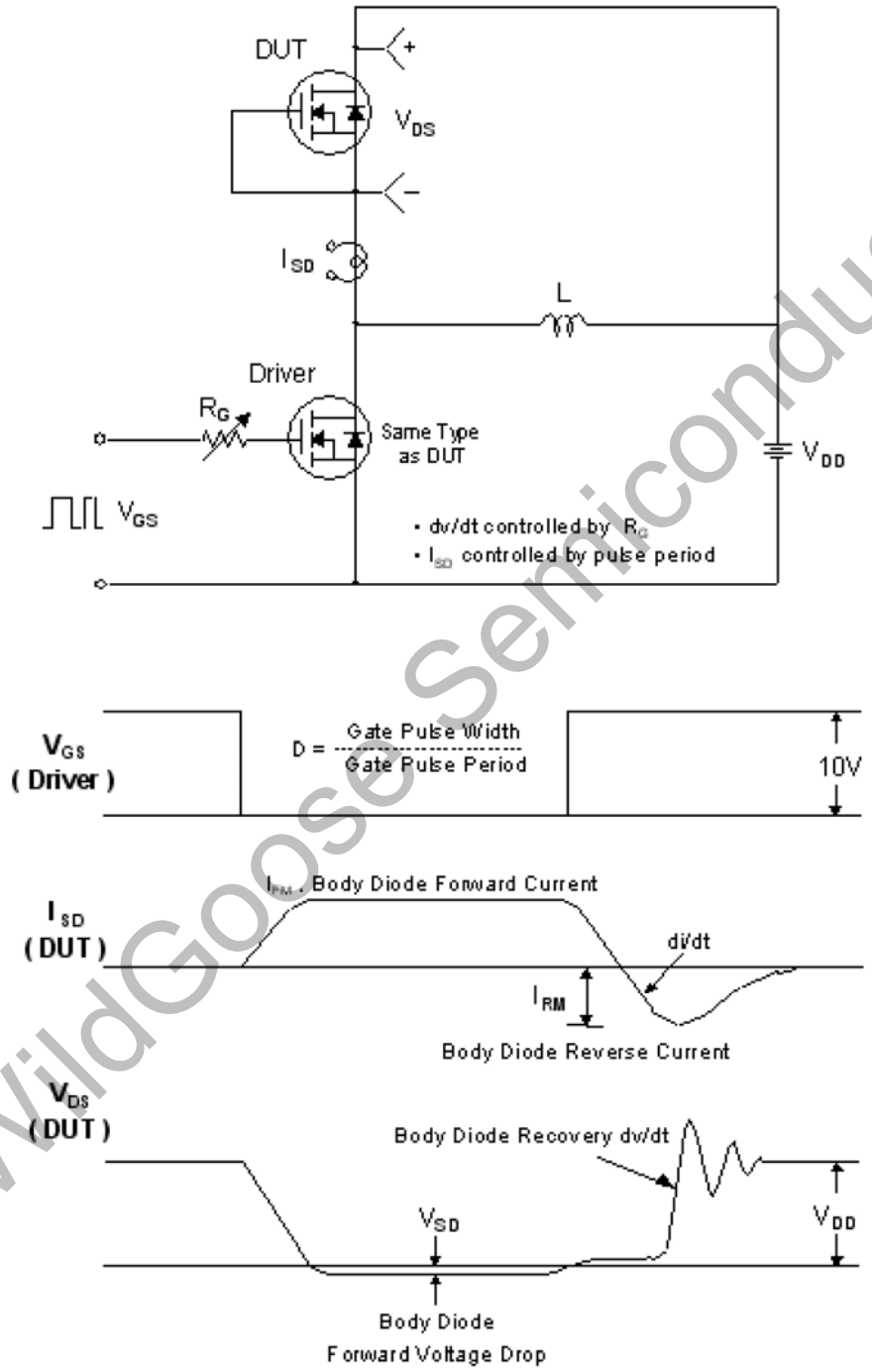
Unclamped Inductive Switching Test Circuit & Waveforms



$$E_{AS} = \frac{1}{2} L I_{AS}^2 \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$



Peak Diode Recovery dv/dt Test Circuit & Waveform



Package Dimension

TO-220

Unit: mm